SDAS227A - JUNE 1984 - REVISED JANUARY 1995

- 3-State I/O-Type Read-Back Inputs
- Bus-Structured Pinout
- Choice of True or Inverting Logic
  - SN74ALS666 . . . True Outputs
  - SN74ALS667 . . . Inverted Outputs
- Preset and Clear Inputs
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (NT) 300-mil DIPs

#### description

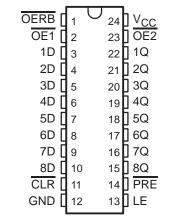
These 8-bit D-type transparent latches are designed specifically for storing the contents of the input data bus, plus reading back the stored data onto the input data bus. In addition, they provide a 3-state buffer-type output and are easily utilized in bus-structured applications.

While the latch enable (LE) is high, the Q outputs of the SN74ALS666 follow the data (D) inputs. The  $\overline{\mathbb{Q}}$  outputs of the SN74ALS667 provide the inverse of the data applied to its D inputs. The Q or  $\overline{\mathbb{Q}}$  output of both devices is in the high-impedance state if either output-enable ( $\overline{\mathsf{OE1}}$  or  $\overline{\mathsf{OE2}}$ ) input is at a high logic level.

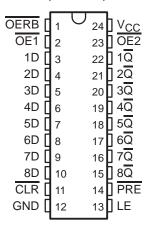
Read back is provided through the read-back control (OERB) input. When OERB is taken low, the data present at the output of the data latches passes back onto the input data bus. When OERB is taken high, the output of the data latches is isolated from the D inputs. OERB does not affect the internal operation of the latches; however, caution should be exercised to avoid a bus conflict.

The SN74ALS666 and SN74ALS667 are characterized for operation from 0°C to 70°C.

# SN74ALS666 . . . DW OR NT PACKAGE (TOP VIEW)

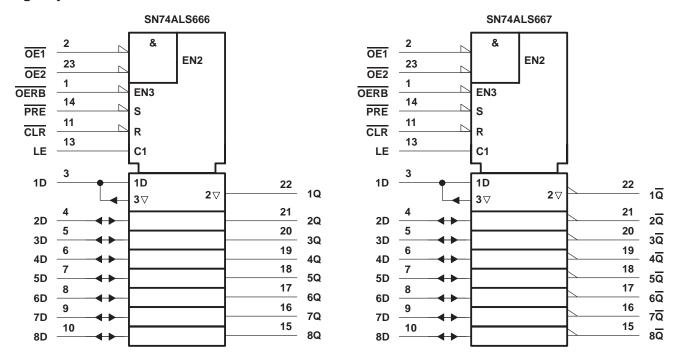


# SN74ALS667 . . . DW OR NT PACKAGE (TOP VIEW)



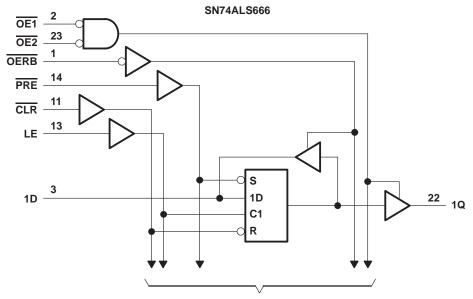
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### logic symbols†

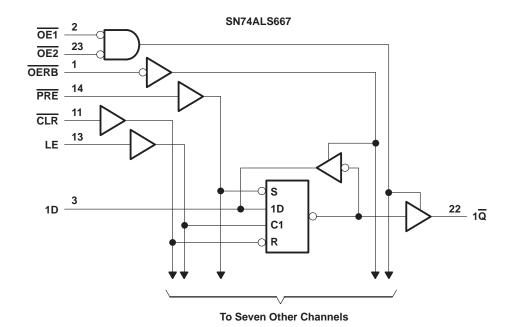


<sup>†</sup> These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

## logic diagrams (positive logic)

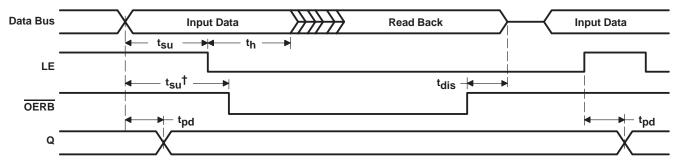


To Seven Other Channels



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#### timing diagram



 $\overline{\text{CLR}} = \text{H}, \overline{\text{PRE}} = \text{H}, \overline{\text{OE1}} = \text{L}, \overline{\text{OE2}} = \text{L}.$ 

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub> (all inputs except D inputs)	7 V
Voltage applied to D inputs and to disabled 3-state outputs	5.5 V
Operating free-air temperature range, T <sub>A</sub> : SN74ALS666, SN74ALS667	0°C to 70°C
Storage temperature range	–65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions

				74ALS6		UNIT	
			MIN	NOM	MAX		
VCC	V <sub>CC</sub> Supply voltage					V	
VIH	High-level input voltage		2			V	
$V_{IL}$	Low-level input voltage				0.8	V	
lou	OH High-level output current	Q			-2.6	mA	
ЮН		D			-0.4	IIIA	
lo.	Low-level output current	Q			24	4 mA	
lOL	Low-level output current	D			8	IIIA	
		LE high	10				
t <sub>W</sub>	Pulse duration	CLR low				ns	
		PRE low	10				
	Satura tima	Data before LE↓	10			no	
t <sub>su</sub>	Setup time Data before OERB↓		10			ns	
th	Hold time, data after LE↓		5			ns	
TA	Operating free-air temperature		0		70	°C	

<sup>†</sup> This setup time ensures the read-back circuit does not create a conflict on the input data bus.

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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CON	TEST CONDITIONS				UNIT	
				MIN	TYP <sup>†</sup>	MAX		
٧ıK		V <sub>CC</sub> = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.2	V	
V	All outputs	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2			V	
VOH	Q or Q	$V_{CC} = 4.5 V,$	$I_{OH} = -2.6 \text{ mA}$	2.4	3.2		V	
	D inputs	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 4 mA		0.25	0.4		
\/ a.	Dilipuis	∨CC = 4.5 V	$I_{OL} = 8 \text{ mA}$		0.35	0.5	V	
VOL	0 0 0	V00 = 45 V	I <sub>OL</sub> = 12 mA		0.25	0.4	1 '	
	Q or Q	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 24 mA		0.35	0.5		
lozh	Q or Q	$V_{CC} = 5.5 V$ ,	$V_0 = 2.7 \text{ V}$			20	μΑ	
lozL	Q or Q	$V_{CC} = 5.5 V$ ,	V <sub>O</sub> = 0.4 V			-20	μΑ	
1.	D inputs	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 5.5 V			0.1	mA	
'	All others	vCC = 2:2 v	V <sub>I</sub> = 7 V			0.1	IIIA	
1	D inputs‡	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20		
lН	All others	vCC = 5.5 v,	V   = 2.7 V			20	μΑ	
1	D inputs‡	V00 - 5 5 V	\\\ - 0.4\\			-0.1	mA	
II∟	All others	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.1	IIIA	
IO§		$V_{CC} = 5.5 V$ ,	V <sub>O</sub> = 2.25 V	-30		-112	mA	
			Q outputs high		25	50		
	SN74ALS666	74ALS666 $\frac{V_{CC} = 5.5 \text{ V,}}{\text{OERB high}}$	Q outputs low		40	73		
			Q outputs disabled		30	55	^	
ICC			Q outputs high		25	50	mA	
	SN74ALS667	<u>VCC =</u> 5.5 V, OERB high	Q outputs low		45	79		
			Q outputs disabled		30	60		

<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. ‡ For I/O ports (Q<sub>A</sub> through Q<sub>H</sub>), the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current.

<sup>§</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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#### switching characteristics (see Figure 1)

PARAMETER	FROM	то	V <sub>CC</sub> = 4.5 C <sub>L</sub> = 50 pF T <sub>A</sub> = MIN to	UNIT	
	(INPUT)	(OUTPUT)	SN74A		
			MIN	MAX	
t <sub>PLH</sub>	D		3	14	ns
<sup>t</sup> PHL	ט	Q	4	18	115
t <sub>PLH</sub>	LE		6	21	ns
<sup>t</sup> PHL	LL	Q	8	27	115
<b>†</b> D	CLR	Q	9	29	ns
<sup>t</sup> PHL		D	11	32	113
t <sub>PLH</sub>	PRE	Q	7	22	ns
t <sub>PHL</sub>	PRE	D	9	28	115
t <sub>en</sub> ‡	OERB	D	4	21	
	OE1, OE2	Q	4	21	ns
t <sub>dis</sub> §	OERB	D	1	14	
	OE1, OE2	Q	1	14	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics (see Figure 1)

PARAMETER	FROM	то	V <sub>CC</sub> = 4.5 C <sub>L</sub> = 50 pF T <sub>A</sub> = MIN to	UNIT	
.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	(INPUT)	(OUTPUT)	SN74A		
			MIN	MAX	
t <sub>PLH</sub>	D	Q	6	20	ns
<sup>t</sup> PHL	U	Q	4	15	113
t <sub>PLH</sub>	LE	ā	9	28	ns
t <sub>PHL</sub>	LL	Q	7	22	ns
4	CLR	ĪQ	7	24	ns
t <sub>PHL</sub>		D	8	26	
t <sub>PLH</sub>	PRE	Q	8	25	ns
t <sub>PHL</sub>	PRE	D	9	28	115
. +	OERB	D	4	21	
t <sub>en</sub> ‡	OE1, OE2	Q	4	21	ns
8	OERB	D	1	14	20
t <sub>dis</sub> §	OE1, OE2	Q	1	14	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



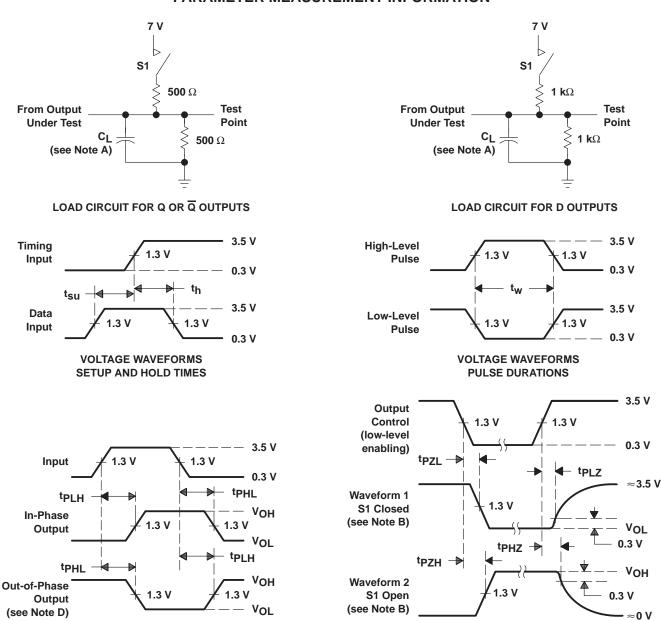
 $t_{en} = t_{PZH} \text{ or } t_{PZL}$   $t_{dis} = t_{PHZ} \text{ or } t_{PLZ}$ 

 $t_{en} = t_{PZH} \text{ or } t_{PZL}$  $t_{dis} = t_{PHZ} \text{ or } t_{PLZ}$ 

**VOLTAGE WAVEFORMS** 

**ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS** 

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

**VOLTAGE WAVEFORMS** 

PROPAGATION DELAY TIMES

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- D. When measuring propagation delay times of 3-state outputs, switch S1 is open.

Figure 1. Load Circuits and Voltage Waveforms



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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74ALS666DW	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS666
SN74ALS666DW.A	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS666
SN74ALS667DW	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS667
SN74ALS667DW.A	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	ALS667

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ALS666DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS666DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS667DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ALS667DW.A	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

## PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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